Product Preview

# Power MOSFET and Schottky Diode

30 V, N–Channel with 0.5 A Schottky Barrier Diode, 1.6 x 1.6 x 0.55 mm μCool<sup>™</sup> Package

## Features

- Low Qg and Capacitance to Minimize Switching Losses
- Low Profile UDFN 1.6 x 1.6 x 0.55 mm for Board Space Saving
- Low VF Schottky diode
- Halide Free
- Lead Free Package
- ESD Protected Gate

## Applications

- DC-DC Boost Converter
- Color Display and Camera Flash Regulators
- Optimized for Power Management Applications for Portable Products, such as Cell Phones, PMP, DSC, GPS, and others

## **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise stated)

Par	ameter		Symbol	Value	Units
Drain-to-Source Vol	tage		V <sub>DSS</sub>	30	V
Gate-to-Source Volt	Gate-to-Source Voltage			±8.0	V
Continuous Drain	Steady	$T_A = 25^{\circ}C$	I <sub>D</sub>	1.3	А
Current (Note 1)	State	T <sub>A</sub> = 85°C		1.0	
	t ≤ 5 s	T <sub>A</sub> = 25°C		1.4	
Power Dissipation (Note 1)	Steady State	T <sub>A</sub> = 25°C	P <sub>D</sub>	1.0	W
	t ≤ 5 s	T <sub>A</sub> = 25°C		1.1	
Continuous Drain	Steady	$T_A = 25^{\circ}C$	I <sub>D</sub>	0.8	А
Current (Note 2)	State	T <sub>A</sub> = 85°C		0.6	
Power Dissipation (I	Power Dissipation (Note 2) $T_A = 25^{\circ}C$			0.4	W
Pulsed Drain Current tp = 10 μs			I <sub>DM</sub>	5.6	А
MOSFET Operating Temperature	MOSFET Operating Junction and Storage Temperature		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C
Schottky Operating Junction & Storage Temperature			Tj, T <sub>STG</sub>	-55 to 125	°C
Source Current (Body Diode) (Note 2)			۱ <sub>S</sub>	1.5	А
Lead Temperature for 1 (1/8" from case for 1		Purposes	ΤL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
- Surface-mounted on FR4 board using the minimum recommended pad size of 30 mm<sup>2</sup>, 2 oz. Cu.

This document contains information on a product under development. ON Semiconductor reserves the right to change or discontinue this product without notice.



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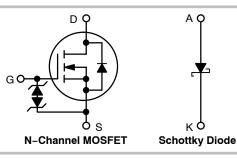
## http://onsemi.com

### MOSFET

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
	250 mΩ @ 4.5 V	
30 V	350 mΩ @ 3.0 V	1.4 A
	425 mΩ @ 2.5 V	

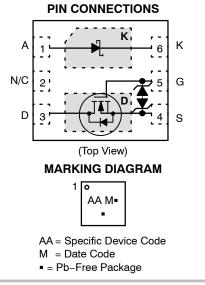
## SCHOTTKY DIODE

V <sub>R</sub> MAX	V <sub>F</sub> TYP	I <sub>F</sub> MAX
30 V	0.52 V	0.5 A





UDFN6 CASE 517AT μCOOL™



## **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

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#### **DEVICE ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTLUF4189NZTAG	UDFN6 (Pb-Free)	3000 / Tape & Reel
NTLUF4189NZTBG	UDFN6 (Pb-Free)	3000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### Schottky Diode Maximum Ratings (T<sub>J</sub> = 25°C unless otherwise stated)

Parameter	Symbol	Value	Units
Peak Repetitive Reverse Voltage	V <sub>RRM</sub>	30	V
DC Blocking Voltage	V <sub>R</sub>	30	V
Average Rectified Forward Current	١ <sub>F</sub>	0.5	А

#### **Thermal Resistance Ratings**

Parameter	Symbol	Max	Units
Junction-to-Ambient – Steady State (Note 3)	$R_{\thetaJA}$	125	°C/W
Junction-to-Ambient – t $\leq$ 5 s (Note 3)	$R_{\thetaJA}$	115	
Junction-to-Ambient – Steady State min Pad (Note 4)	$R_{\thetaJA}$	310	

### MOSFET Electrical Characteristics (T<sub>J</sub> = $25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Units
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, $I_D$ = 250 $\mu$ A		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	$I_D = 250 \ \mu\text{A}$ , ref to $25^{\circ}\text{C}$			22		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V,$ $T_{J} = 25^{\circ}C$				1.0	μΑ
		V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 24 V	$T_J = 85^{\circ}C$			10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V	′ <sub>GS</sub> = ± 8.0 V			10	μΑ

#### **ON CHARACTERISTICS** (Note 5)

Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}$ , $I_D = 250 \ \mu A$	0.4	1.1	1.5	V
Negative Threshold Temp. Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>			3.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS}$ = 4.5 V, I <sub>D</sub> = 0.5 A		130	250	mΩ
		$V_{GS}$ = 3.0 V, I <sub>D</sub> = 0.5 A		170	350	
		$V_{GS}$ = 2.5 V, I <sub>D</sub> = 0.5 A		205	425	
Forward Transconductance	9 <sub>FS</sub>	$V_{DS} = 4.0 \text{ V}, \text{ I}_{D} = 0.15 \text{ A}$		TBD		S

#### **CHARGES & CAPACITANCES**

Input Capacitance	C <sub>ISS</sub>		95		pF
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 15 V	15		
Reverse Transfer Capacitance	C <sub>RSS</sub>		10		
Total Gate Charge	Q <sub>G(TOT)</sub>		1.5	3.0	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 0.5 A	0.2		
Gate-to-Source Charge	Q <sub>GS</sub>	$I_{\rm D} = 0.5$ Å	0.4		
Gate-to-Drain Charge	Q <sub>GD</sub>	]	0.4		

Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces)
 Surface-mounted on FR4 board using the minimum recommended pad size of 30 mm<sup>2</sup>, 2 oz. Cu.

5. Pulse Test: pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2%

6. Switching characteristics are independent of operating junction temperatures

Parameter	Symbol	Test Condition		Min	Тур	Max	Units
SWITCHING CHARACTERISTICS, VG	S = 4.5 V (Note 6)						
Turn-On Delay Time	t <sub>d(ON)</sub>				7.0		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DD</sub> = 15 V,			5.0		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	I <sub>D</sub> = 1A, I	$R_{G} = 6 \Omega$		10		
Fall Time	t <sub>f</sub>				1.0		
DRAIN-SOURCE DIODE CHARACTER	RISTICS						
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$		0.8	1.2	V
		$I_{\rm S} = 1$ A	$T_J = 85^{\circ}C$		0.75		
Reverse Recovery Time	t <sub>RR</sub>		1		7.0		ns
Charge Time	t <sub>a</sub>	Vce = 0 V. dler	o/dt = 100 A/us.		5.0		
Discharge Time	t <sub>b</sub>	$V_{ m GS}$ = 0 V, dI <sub>SE</sub> I <sub>S</sub> =	1 A		2.0		
Reverse Recovery Charge	Q <sub>RR</sub>				2.0		nC
SCHOTTKY DIODE ELECTRICAL CH	ARACTERISTICS	(T <sub>J</sub> = 25°C unless ot	herwise specified)				
Parameter	Symbol	Test Co	ondition	Min	Тур	Max	Units
Maximum Instantaneous Forward	V <sub>F</sub>	I <sub>F</sub> = 10 mA			0.28	0.37	V
Voltage		I <sub>F</sub> = 10	00 mA		0.37	0.46	
		I <sub>F</sub> = 500 mA			0.52	0.62	
Maximum Instantaneous	I <sub>R</sub>	V <sub>R</sub> =	10 V		1.4	10	μΑ
Reverse Current		V <sub>R</sub> = 20 V V <sub>R</sub> = 30 V			6.0	TBD	
					20	200	
SCHOTTKY DIODE ELECTRICAL CH	ARACTERISTICS	$(T_J = 85^{\circ}C \text{ unless ot})$	herwise specified)				
Maximum Instantaneous	V <sub>F</sub>	I <sub>F</sub> = 1	0 mA		0.2		V
Forward Voltage		I <sub>F</sub> = 10	00 mA		0.31		
		I <sub>F</sub> = 50	00 mA		0.51		
Maximum Instantaneous	I <sub>R</sub>	V <sub>R</sub> =	10 V		70		μA
Reverse Current		V <sub>R</sub> =	20 V		180		
		V <sub>R</sub> = 30 V			500		
SCHOTTKY DIODE ELECTRICAL CH	ARACTERISTICS	$(T_J = 125^{\circ}C \text{ unless } c$	otherwise specified)				
Maximum Instantaneous	V <sub>F</sub>	I <sub>F</sub> = 1	0 mA		0.15		V
Forward Voltage		l <sub>F</sub> = 100 mA			0.28		
		I <sub>F</sub> = 50	00 mA		0.50		
Maximum Instantaneous	I <sub>R</sub>	V <sub>R</sub> =	10 V		600		μΑ
Reverse Current		V <sub>R</sub> =	20 V		1300		
		V <sub>R</sub> =	30 V		3000		
SCHOTTKY DIODE ELECTRICAL CH	ARACTERISTICS	(T <sub>J</sub> = 25°C unless ot	herwise specified)				
Capacitance	С	V <sub>R</sub> = 5 V, f	= 1.0 MHz		6.0		pF

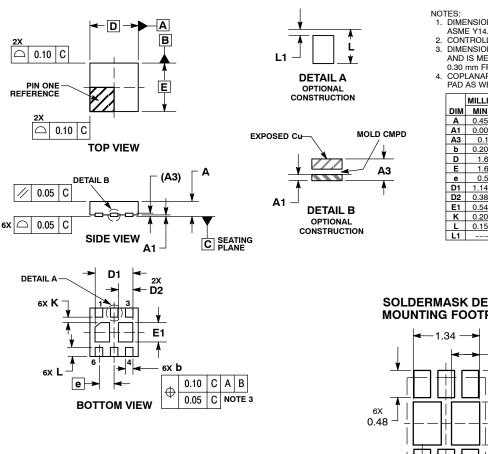
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 Surface-mounted on FR4 board using the minimum recommended pad size of 30 mm<sup>2</sup>, 2 oz. Cu.

5. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%

6. Switching characteristics are independent of operating junction temperatures

#### PACKAGE DIMENSIONS

UDFN6 1.6x1.6, 0.5P CASE 517AT-01 **ISSUE O** 

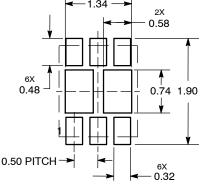


DIMENSIONING AND TOLERANCING PER

- ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS. DIMENSION 6 APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND
- 0.30 mm FROM TERMINAL. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

	MILLIM	ETERS				
DIM	MIN MAX					
Α	0.45	0.55				
A1	0.00	0.05				
A3	0.13	REF				
b	0.20	0.30				
D	1.60 BSC					
Е	1.60	BSC				
е	0.50	BSC				
D1	1.14	1.34				
D2	0.38	0.58				
E1	0.54	0.74				
K	0.20					
L	0.15	0.35				
L1		0.10				

SOLDERMASK DEFINED **MOUNTING FOOTPRINT\*** 



DIMENSIONS: MILLIMETERS

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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